

Silicon Carbide Power MOSFET N-Channel Enhancement Mode

Features

- · Optimized package with separate driver source pin
- Lower profile TO-247-4 package body
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q,,)
- · Halogen free, RoHS compliant

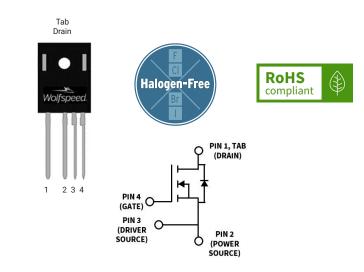
Benefits

- · Reduce switching losses and minimize gate ringing
- Higher system efficiency
- · Reduce cooling requirements
- Increase power density
- Increase system switching frequency

Typical Applications

- Motor Control
- EV Battery Chargers
- High Voltage DC/DC Converters
- Solar/ESS
- UPS
- Enterprise PSU

Package



Part Number	Package	Marking		
C3M0160120K1	T0-247-4L LP	C3M0160120K1		

Key Parameters

Parameter	Symbol	Min.	Тур.	Max	Unit	Conditions	Note
Drain - Source Voltage	V _{DS}			1200		T _c = 25°C	
Maximum Gate - Source Voltage	V _{GS(max)}	-8		+19	V	Transient	
Operational Gate-Source Voltage	V _{GS op}		-4/15			Static	Note 1
				17.9		$V_{GS} = 15 \text{ V}, T_{C} = 25 \text{ °C}, T_{J} \le 175 \text{ °C}$	Fig. 19
DC Continuous Drain Current	l _D			13.5	A	$V_{GS} = 15 \text{ V}, T_{C} = 100 \text{ °C}, T_{J} \le 175 \text{ °C}$	Note 2
Pulsed Drain Current	I _{DM}			34		t_{Pmax} limited by T_{jmax} $V_{GS} = 15V, T_{C} = 25 °C$	Fig. 22
Power Dissipation	P _D			103	W	$T_c = 25 ^{\circ} \text{C}, T_J = 175 ^{\circ} ^{\circ} ^{\circ}$	Fig. 20
Operating Junction and Storage Temperature	T _J , T _{stg}			-40 to +175	°C		
Solder Temperature	T _L			260		According to JEDEC J-STD-020	
Mounting Torque	M _D			1 8.8	Nm lbf-in	M3 or 6-32 screw	

Note (1): Recommended turn-on gate voltage is 15V with ±5% regulation tolerance, see Application Note PRD-04814 for additional details Note (2): Verified by design

Electrical Characteristics ($T_c = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	Note
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	1200			٧	V _{GS} = 0 V, I _D = 100 μA	
\/	Code Threehold Velders	1.8	2.8	3.8	V	V _{DS} = V _{GS} , I _D = 2.33 mA	Fin. 11
$V_{GS(th)}$	Gate Threshold Voltage		2.2		V	V _{DS} = V _{GS} , I _D = 2.33 mA, T _J = 175°C	Fig. 11
I_{DSS}	Zero Gate Voltage Drain Current		1	50	μA	V _{DS} = 1200 V, V _{GS} = 0 V	
I_{GSS}	Gate-Source Leakage Current		10	250	nA	$V_{GS} = 15 \text{ V}, V_{DS} = 0 \text{ V}$	
R _{DS(on)}	Drain-Source On-State Resistance		159	208	mΩ	$V_{GS} = 15 \text{ V, } I_D = 8.5 \text{ A}$	Fig. 4, 5, 6
US(on)	Stant Source on State Nesistance		280	<u> </u>		V _{GS} = 15 V, I _D = 8.5 A, T _J = 175°C	
g_{fs}	Transconductance		4.9	<u> </u>	s	V _{DS} = 20 V, I _{DS} = 8.5 A	Fig. 7
915			4.6			V _{DS} = 20 V, I _{DS} = 8.5 A, T _J = 175°C	19.7
C _{iss}	Input Capacitance		730		_		
C_{oss}	Output Capacitance		31		pF	$V_{GS} = 0 \text{ V}, V_{DS} = 0 \text{V to } 1000 \text{ V}$	Fig. 17, 18
C_{rss}	Reverse Transfer Capacitance		2			F = 1 MHz	
E _{oss}	C _{oss} Stored Energy		17		μJ	- V _{AC} = 25 mV	Fig. 16
C _{o(er)}	Effective Output Capacitance (Energy Related)		36		pF		Note: 3
C _{o(tr)}	Effective Output Capacitance (Time Related)		55		pF	$V_{GS} = 0 \text{ V, } V_{DS} = 0 800 \text{ V}$	
E _{on}	Turn-On Switching Energy (External Diode)		81			V_{DS} = 800 V, V_{GS} = -4 V/15 V, I_{D} = 8.5 A, $R_{G(ext)}$ = 2.5 Ω, L= 404 μH, T_{J} = 175°C FWD = External SiC DIODE	Fig. 26, 28
E _{OFF}	Turn Off Switching Energy (External Diode)		16		μJ		
Eon	Turn-On Switching Energy (Body Diode FWD)		134			V_{DS} = 800 V, V_{GS} = -4 V/15 V, I_{D} = 8.5 A,	Fig. 26, 28
E _{OFF}	Turn-Off Switching Energy (Body Diode FWD)		15		μJ	$R_{G(ext)}$ = 2.5 Ω, L= 404 μH, T_J = 175°C FWD = Internal Body Diode	
$t_{\text{d(on)}}$	Turn-On Delay Time		8				Fig. 27, 28
t _r	Rise Time		9			$\begin{split} V_{DD} &= 800 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V} \\ I_D &= 8.5 \text{ A}, R_{G(ext)} = 2.5 \Omega, \\ \text{Timing relative to V}_{DS} \\ \text{Inductive load} \end{split}$	
$t_{\text{d(off)}} \\$	Turn-Off Delay Time		13		ns		
t _f	Fall Time		12]		
R _{G(int)}	Internal Gate Resistance		6.5		Ω	f = 1 MHz, V _{AC} = 25 mV	
Q_{gs}	Gate to Source Charge		10			V _{DS} = 800 V, V _{GS} = -4 V/15 V	
Q_{gd}	Gate to Drain Charge		12]	nC	$I_D = 8.5 \text{ A}$	Fig. 12
Qg	Total Gate Charge		32]		Per IEC60747-8-4 pg 21	

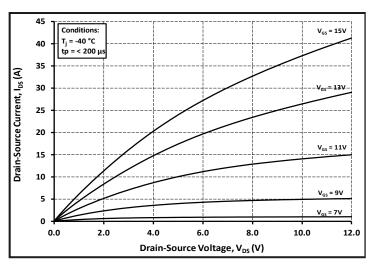
Note (3): $C_{O(er)}$, a lumped capacitance that gives same stored energy as Coss while Vds is rising from 0 to 800V $C_{O(tr)}$, a lumped capacitance that gives same charging time as Coss while Vds is rising from 0 to 800V

Reverse Diode Characteristics ($T_c = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter	Тур.	Max.	Unit	Test Conditions	Note
V	Diada Farward Voltaga	4.8		٧	V_{GS} = -4 V, I_{SD} = 4.25 A, T_{J} = 25 °C	Fig. 8,
V _{SD}	Diode Forward Voltage	4.2		V	$V_{GS} = -4 \text{ V, I}_{SD} = 4.25 \text{ A, T}_{J} = 175 \text{ °C}$	9, 10
Is	Continuous Diode Forward Current		17	Α	V _{GS} = -4 V, T _C = 25°C	
I _{SM}	Diode pulse Current		34	Α	V_{GS} = -4 V, pulse width t_p limited by T_{jmax}	
t _{rr}	Reverse Recover time	9		ns		
Q _{rr}	Reverse Recovery Charge	169		nC	V _{GS} = -4 V, I _{SD} = 8.5 A, V _R = 800 V dif/dt = 6080 A/μs, Τ _ι = 175 °C	
I _{rrm}	Peak Reverse Recovery Current	27		А		
t _{rr}	Reverse Recover time	23		ns		
Q _{rr}	Reverse Recovery Charge	147		nC	V _{GS} = -4 V, I _{SD} = 8.5 A, V _R = 800 V dif/dt = 1850 A/μs, Τ _ι = 175 °C	
I _{rrm}	Peak Reverse Recovery Current	11		А	α,α. 1999 / γ μος 1, 170 θ	

Thermal Characteristics

Symbol	Parameter	Тур.	Unit	Test Conditions	Note
$R_{ heta JC}$	Thermal Resistance from Junction to Case	1.13	°C/W		Fig. 21



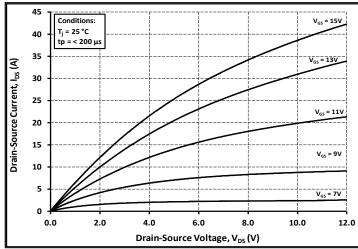
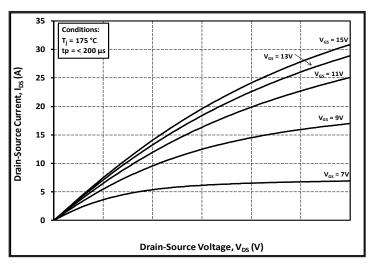


Figure 1. Output Characteristics T_J = -40 °C

Figure 2. Output Characteristics T_J = 25 °C



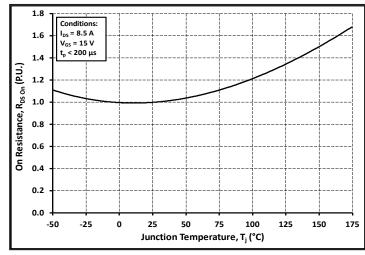
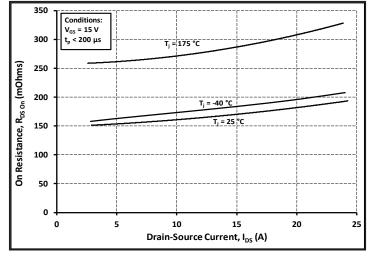


Figure 3. Output Characteristics T_J = 175 °C

Figure 4. Normalized On-Resistance vs. Temperature



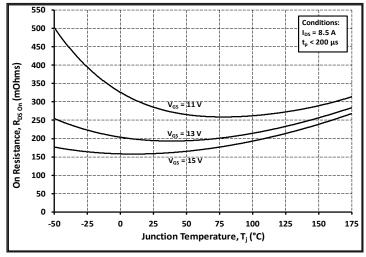


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

Figure 6. On-Resistance vs. Temperature For Various Gate Voltage

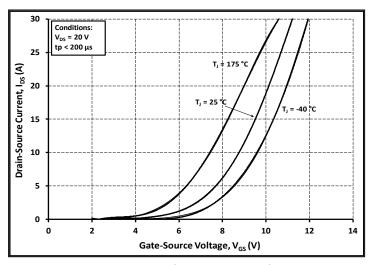


Figure 7. Transfer Characteristic for Various Junction Temperatures

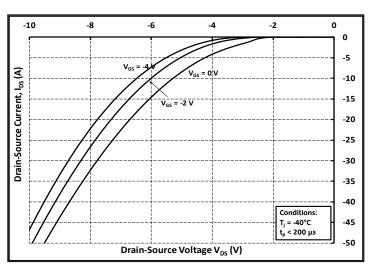


Figure 8. Body Diode Characteristic at -40 °C

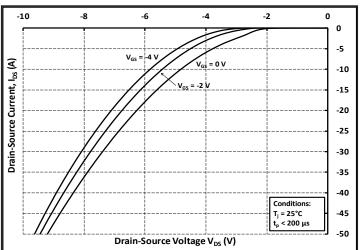


Figure 9. Body Diode Characteristic at 25 °C

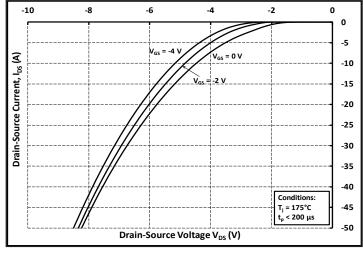


Figure 10. Body Diode Characteristic at 175 °C

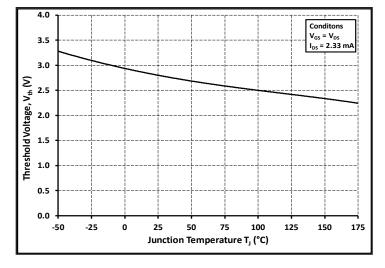


Figure 11. Threshold Voltage vs. Temperature

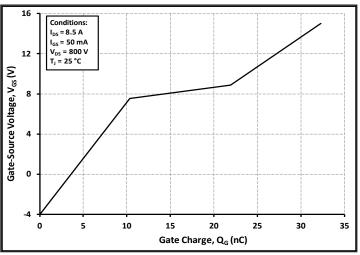


Figure 12. Gate Charge Characteristics

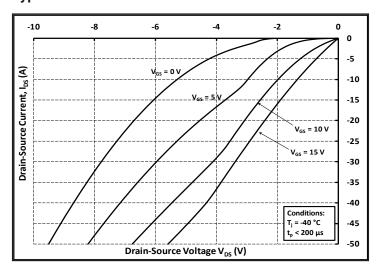


Figure 13. 3rd Quadrant Characteristic at -40 °C

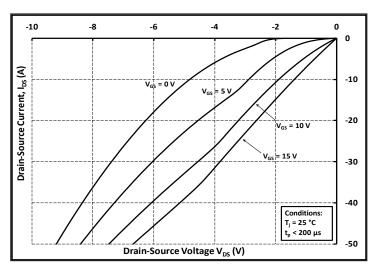


Figure 14. 3rd Quadrant Characteristic at 25 °C

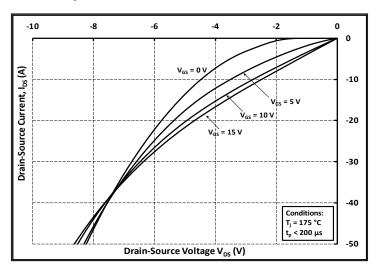


Figure 15. 3rd Quadrant Characteristic at 175 °C

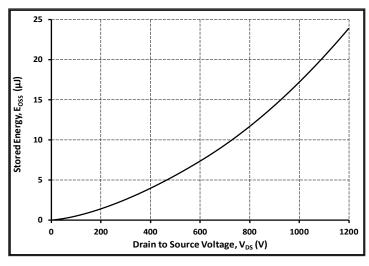


Figure 16. Output Capacitor Stored Energy

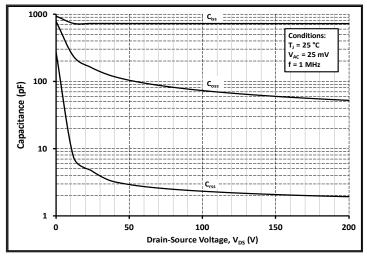


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

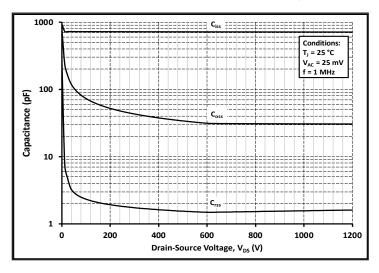
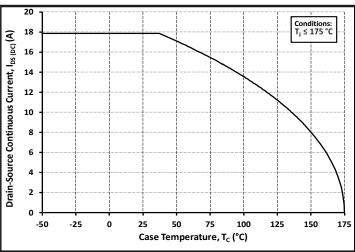


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1200V)





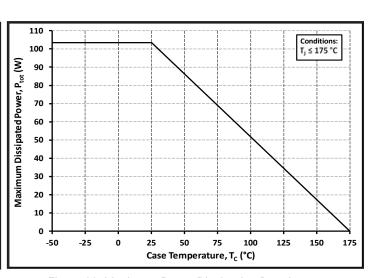


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

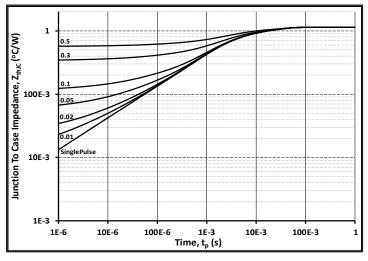


Figure 21. Transient Thermal Impedance (Junction - Case)

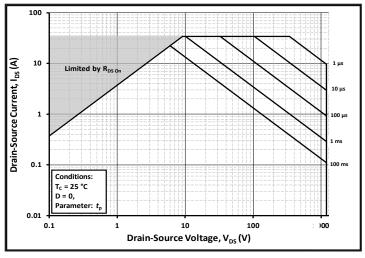


Figure 22. Safe Operating Area

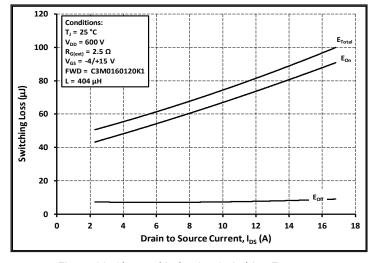


Figure 23. Clamped Inductive Switching Energy vs. Drain Current $(V_{DD} = 600V)$

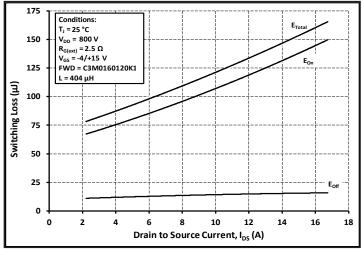


Figure 24. Clamped Inductive Switching Energy vs. Drain Current (V_{DD} = 800V)

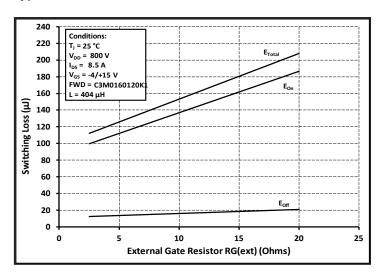


Figure 25. Clamped Inductive Switching Energy vs. $R_{G(ext)}$

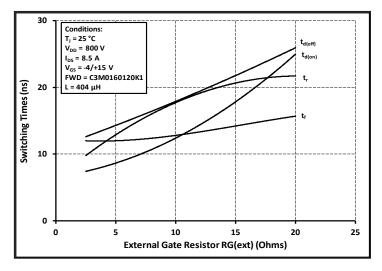


Figure 27. Switching Times vs. $R_{G(ext)}$

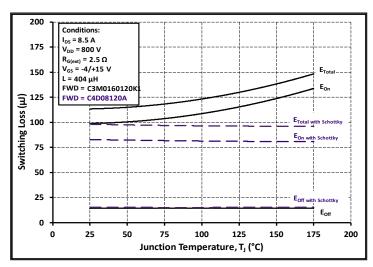


Figure 26. Clamped Inductive Switching Energy vs.
Temperature

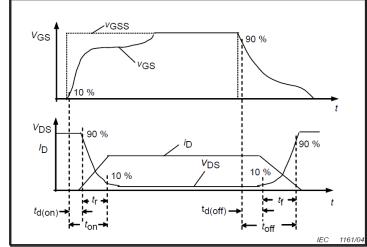


Figure 28. Switching Times Definition

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Test Circuit Schematic

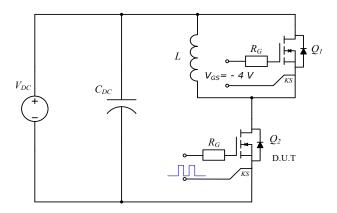
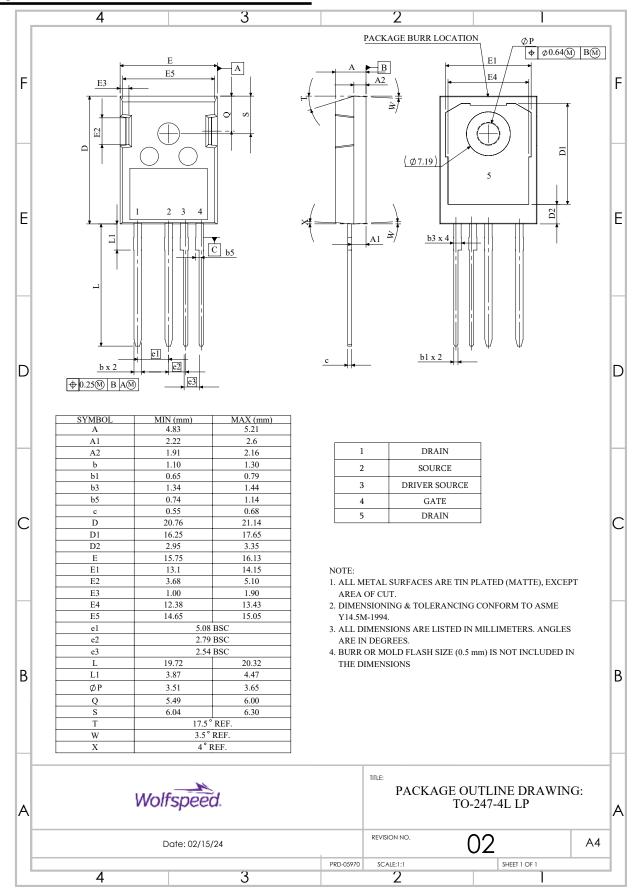


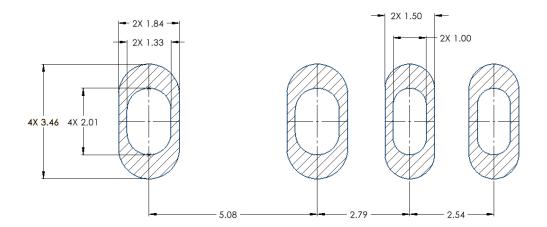
Figure 29. Clamped Inductive Switching Waveform Test Circuit

Package Dimensions



Recommended Solder Pad Layout

All dimensions in mm



Revision history

Document Version	Date of release	Descriptiion of changes
1.0	April-2024	Initial datasheet
2.0	October - 2024	Legal Disclaimer

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Contact info:

4600 Silicon Drive Durham, NC 27703 USA Tel: +1.919.313.5300 www.wolfspeed.com/power

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